

APPLICATION NOTE

mitsubishi<IGBT MODULE>

Tentative

CM100RL-12NF

Pre.	M.Koura	Rev	B	H.Hanada, M.Koura
Apr.	T.Furue 27-Nov.-'03			T.Furue 20-May-'84

HIGH POWER SWITCHING USE

Notice : This is not a final specification. Some parametric limits are subject to change.

CM100RL-12NF	
●I _c	100A
●V _{CES}	600V
●Insulated Type	
●7-elements in a pack	

APPLICATION

AC drive inverters & Servo controls,etc

ABSOLUTE MAXIMUM RATINGS (T_j = 25 °C)

Inverter part

Symbol	Item	Conditions	Ratings	Units
V _{CES}	Collector-emitter voltage	G-E Short	600	V
V _{GES}	Gate-emitter voltage	C-E Short	±20	
I _c	Collector current	DC, T _c =99°C *1	100	A
I _{CM}		Pulse ②	200	
I _E ①	Emitter current		100	
I _{EM} ①		Pulse ②	200	
P _c ③	Maximum collector dissipation	T _c = 25 °C	540	W

Brake part

Symbol	Item	Conditions	Ratings	Units
V _{CES}	Collector-emitter voltage	G-E Short	600	V
V _{GES}	Gate-emitter voltage	C-E Short	±20	
I _c	Collector current	DC, T _c =107°C *1	50	A
I _{CM}		Pulse ②	100	
P _c ③	Maximum collector dissipation	T _c = 25 °C	320	W
V _{RRM}	Repetitive peak reverse voltage	Clamp diode part	600	V
I _{FM}	Forward current	Clamp diode part	50	A

(Common rating)

Symbol	Item	Conditions	Ratings	Units
T _j	Junction temperature		-40~+150	°C
T _{stg}	Storage temperature		-40~+125	
Viso	Isolation voltage	Main terminal to base plate,AC 1 min.	2500	V
—	Torque strength	Main terminal M5	2.5~3.5	N·m
—	Torque strength	Mounting holes M5	2.5~3.5	
—	Weight	Typical value	350	g

ELECTRICAL CHARACTERISTICS ($T_j = 25\text{ }^\circ\text{C}$)

Inverter part

Symbol	Item	Conditions	Min.	Typ.	Max.	Units	
I_{CES}	Collector cutoff current	$V_{CE}=V_{CES}, V_{GE}=0V$	—	—	1	mA	
$V_{GE(th)}$	Gate-emitter threshold voltage	$I_C=10mA, V_{CE}=10V$	6	7	8	V	B
I_{GES}	Gate leakage current	$V_{GE}=V_{GES}, V_{CE}=0V$	—	—	0.5	μA	
$V_{CE(sat)}$	Collector to emitter saturation voltage	$T_j=25\text{ }^\circ\text{C}$ $I_C=100A$	—	1.7	2.2	V	
		$T_j=125\text{ }^\circ\text{C}$ $V_{GE}=15V$	—	1.7	—		
C_{ies}	Input capacitance	$V_{CE}=10V$ $V_{GE}=0V$	—	—	15	nF	
C_{oes}	Output capacitance		—	—	1.9		
C_{res}	Reverse transfer capacitance		—	—	0.6		
Q_G	Total gate charge	$V_{CC}=300V, I_C=100A, V_{GE}=15V$	—	400	—	nC	
$t_{d(on)}$	Turn-on delay time	$V_{CC}=300V, I_C=100A$ $V_{GE1}=V_{GE2}=15V$ $R_G=6.3\Omega$, Inductive load switching operation $I_E=100A$	—	—	120	ns	A
t_r	Turn-on rise time		—	—	100		
$t_{d(off)}$	Turn-off delay time		—	—	300		
t_f	Turn-off fall time		—	—	300		
t_{rr} ①	Reverse recovery time		—	—	120		
Q_{rr} ①	Reverse recovery charge	—	2.1	—	μC	A	
V_{EC} ①	Emitter-collector voltage	$I_E=100A, V_{GE}=0V$	—	—	2.8	V	B
$R_{th(j-c)Q}$	Thermal resistance	IGBT part (1/6 module) *1	—	—	0.23	$^\circ\text{C/W}$	
$R_{th(j-c)R}$	Thermal resistance	FWDI part (1/6 module) *1	—	—	0.41		
$R_{th(c-f)}$	Contact thermal resistance	Case to fin, Thermal compound Applied (1/6 module) *2	—	0.085	—		
R_g	External gate resistance		6.3	—	63	Ω	B

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MITSUBISHI<IGBT MODULE> CM100RL-12NF HIGH POWER SWITCHING USE

Brake Part

Symbol	Item	Conditions	Min.	Typ.	Max.	Units
I_{CES}	Collector cutoff current	$V_{CE}=V_{CES}, V_{GE}=0V$	—	—	1	mA
$V_{GE(th)}$	Gate-emitter threshold voltage	$I_C=5.0mA$	6	7	8	V
I_{GES}	Gate leakage current	$V_{GE}=V_{GES}, V_{CE}=0V$	—	—	0.5	μA
$V_{CE(sat)}$	Collector to emitter saturation voltage	$T_J=25^\circ C$ $I_C=50A$	—	1.7	2.2	V
		$T_J=125^\circ C$ $V_{GE}=15V$	—	1.7	—	
C_{ies}	Input capacitance	$V_{CE}=10V$ $V_{GE}=0V$	—	—	7.5	nF
C_{oes}	Output capacitance		—	—	1.0	
C_{res}	Reverse transfer capacitance		—	—	0.3	
Q_G	Total gate charge	$V_{CC}=300V, I_C=50A, V_{GE}=15V$	—	200	—	nC
V_{FM}	Forward voltage drop	$I_F=50A$			2.6	V
$R_{th(j-c)Q}$	Thermal resistance	IGBT part *1	—	—	0.39	°C/W
$R_{th(j-c)R}$		Clamp diode part *1	—	—	0.70	

*1: Tc measured point is just under the chips.

If you use this value, $R_{th(f-a)}$ should be measured just under the chips.

*2: Typical value is measured by using Shin-etsu Silicone "G-746".

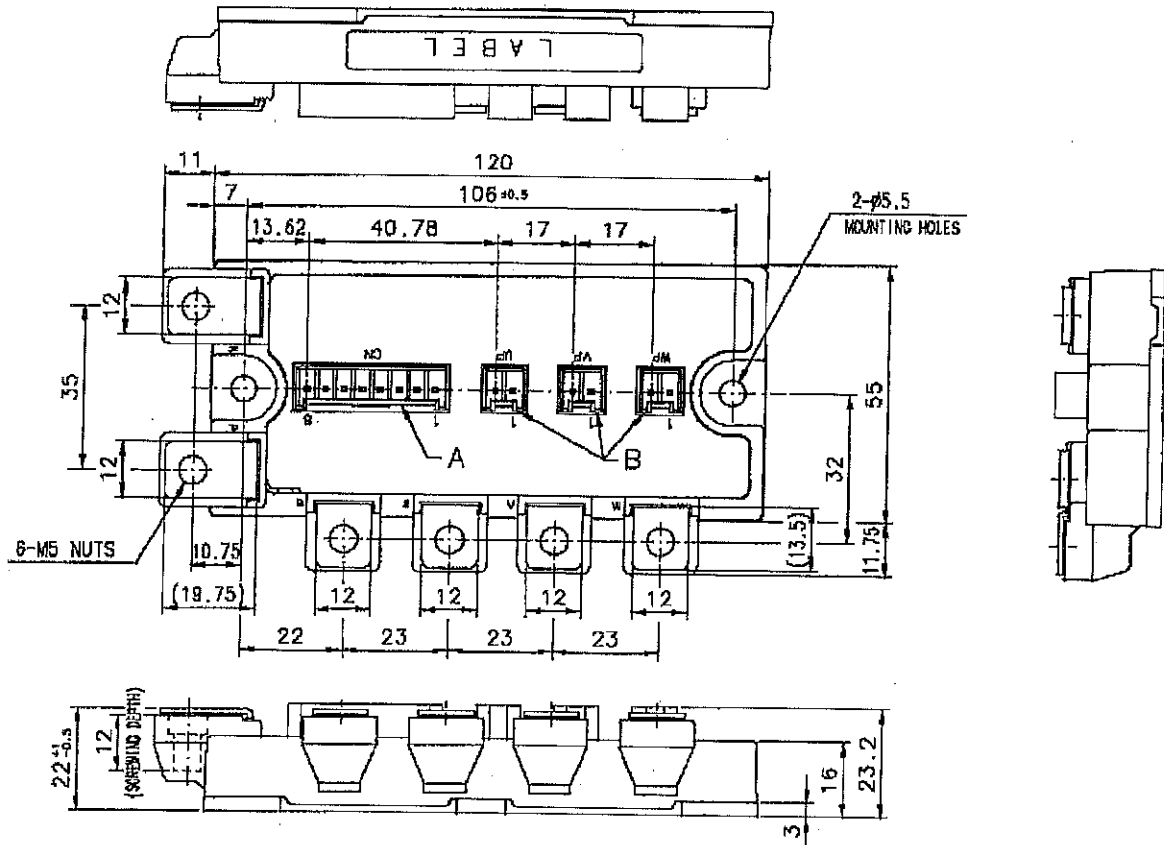
- ① $I_E, V_{EC}, t_{rr}, Q_{rr}$ represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD).
- ② Pulse width and repetition rate should be such that the device junction temp. (T_J) does not exceed T_{jmax} rating.
- ③ Junction temperature (T_J) should not increase beyond 150°C.
- ④ Pulse width and repetition rate should be such as to cause negligible temperature rise.

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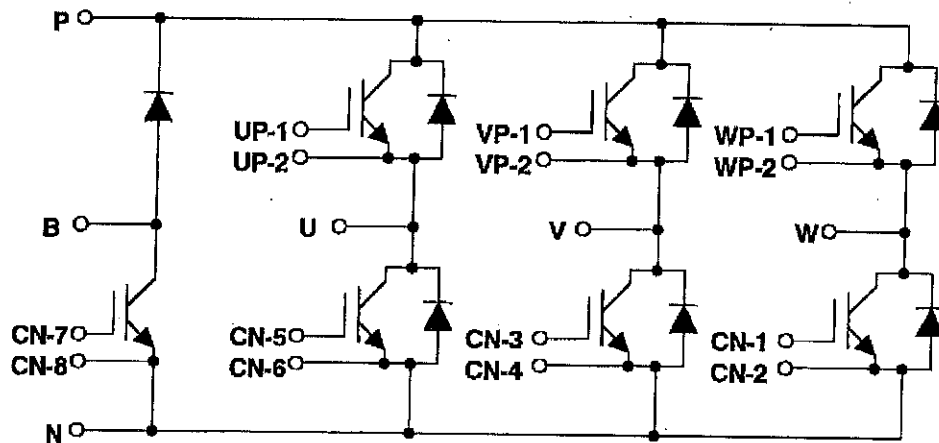
MITSUBISHI <IGBT MODULE>
CM100RL-12NF
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OUTLINE DRAWING

Dimensions in mm



CIRCUIT DIAGRAM



CHIP LAYOUT DRAWING

Dimensions in mm

